

### FDZ293P

# P-Channel 2.5 V Specified PowerTrench® BGA MOSFET

#### **Features**

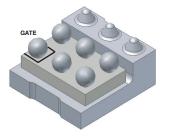
- -4.6 A, -20 V  $R_{DS(ON)} = 46 \text{ m}\Omega$  @  $V_{GS} = -4.5 \text{ V}$  $R_{DS(ON)} = 72 \text{ m}\Omega$  @  $V_{GS} = -2.5 \text{ V}$
- Occupies only 2.25 mm² of PCB area. Less than 50% of the area of a SSOT-6
- Ultra-thin package: less than 0.85 mm height when mounted to PCB
- Outstanding thermal transfer characteristics: 4 times better than SSOT-6
- Ultra-low Q<sub>q</sub> x R<sub>DS(ON)</sub> figure-of-merit
- High power and current handling capability.

### **Applications**

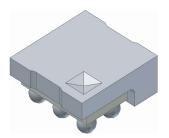
- Battery management
- Load switch
- Battery protection

### **General Description**

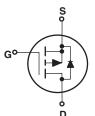
Combining Fairchild's advanced 2.5V specified PowerTrench process with state of the art BGA packaging, the FDZ293P minimizes both PCB space and  $R_{\rm DS(ON)}$ . This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low  $R_{\rm DS(ON)}$ .







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### **Absolute Maximum Ratings** $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Ratings	Units	
V <sub>DSS</sub>	Drain-Source Voltage		-20	V
V <sub>GSS</sub>	Gate-Source Voltage		±12	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	-4.6	Α
	- Pulsed		-10	
P <sub>D</sub>	Power Dissipation for Single Operation (Note 1a)		1.7	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Ra	-55 to +150	°C	

### **Thermal Characteristics**

R <sub>0JA</sub> Thermal Resistance, Junction-to-Ambient (Note 1a)	2 °C/W
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### **Package Marking and Ordering Information**

<b>Device Marking</b>	Device	Reel Size	Tape width	Quantity
В	FDZ293P	7"	8mm	3000 units

# **Electrical Characteristics** $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Тур	Max	Units
Off Charact	teristics					1
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = -250\mu A$ -2				V
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = -250\mu A$ , Referenced to 25°C		-13		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -16V, V_{GS} = 0V$			-1	μΑ
I <sub>GSS</sub>	Gate-Body Leakage.	$V_{GS} = \pm 12V, V_{DS} = 0V$			±100	nA
On Charact	eristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.6	-0.8	-1.5	V
$\Delta V_{GS(th)} \ \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250\mu\text{A}$ , Referenced to 25°C		3		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = -2.5V, I_D = -3.6A,$		36 58 47	46 72 65	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -4.5V, V_{DS} = -5V$	$V_{GS} = -4.5V, V_{DS} = -5V$ -10			Α
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = -5V, I_{D} = -4.6A$		13		S
Dynamic C	haracteristics	•			•	•
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -10V, V_{GS} = 0V,$		754		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0MHz		167		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			92		pF
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 15mV, f = 1.0MHz		6		Ω
Switching (	Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -10V, I_D = -1A,$		11	20	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = -4.5V$ , $R_{GEN} = 6\Omega$		10	20	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			22	35	ns
t <sub>f</sub>	Turn-Off Fall Time			17	31	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = -10V, I_D = -4.6A,$		7.5	11	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -4.5V$		1.5		nC
Q <sub>gd</sub>	Gate-Drain Charge			2.0		nC

2

## **Electrical Characteristics** T<sub>A</sub> = 25°C unless otherwise noted (Continued)

Drain-Source Diode Characteristics and Maximum Ratings						
I <sub>S</sub>	Maximum Continuous Drain—Source Diode Forward Current -1.4 A I <sub>S</sub>			I <sub>S</sub>		
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0V, I_S = -1.4A$ (Note 2)		-0.7	-1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	$I_F = -4.6A$ ,		17		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100A/\mu s$		5		nC

#### Notes:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball,  $R_{\theta JB}$ , is defined for reference. For  $R_{\theta JC}$ , the thermal reference point for the case is defined as the top surface of the copper chip carrier.  $R_{\theta JC}$  and  $R_{\theta JB}$  are guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.



a) 72°C/W when mounted on a 1in2 pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB



b) 157°C/W when mounted on a minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

### **Typical Characteristics**

-50

-25

0 25

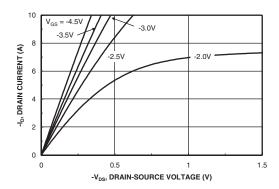
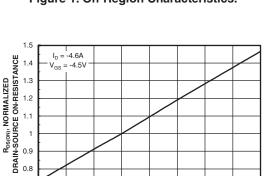


Figure 1. On-Region Characteristics.



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 $T_J$ , JUNCTION TEMPERATURE (°C)

75

100

125

150

Figure 3. On-Resistance Variation with Temperature.

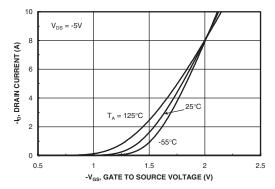


Figure 5. Transfer Characteristics.

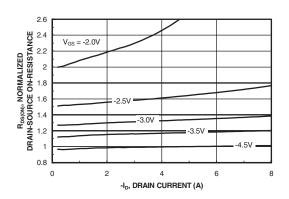


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

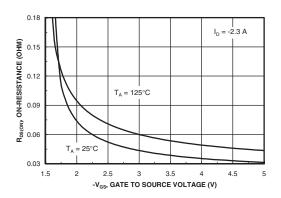


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

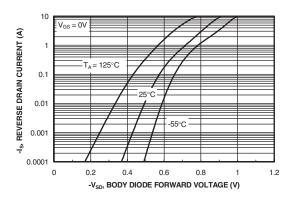


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

### **Typical Characteristics**

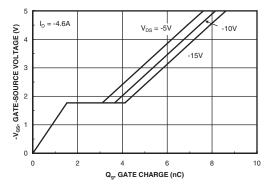


Figure 7. Gate Charge Characteristics.

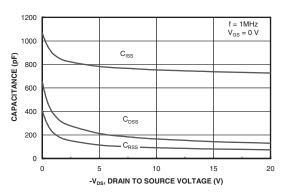


Figure 8. Capacitance Characteristics.

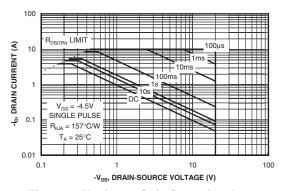


Figure 9. Maximum Safe Operating Area.

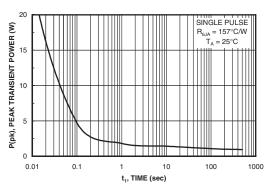


Figure 10. Single Pulse Maximum Power Dissipation.

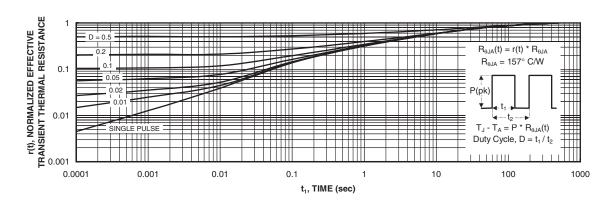
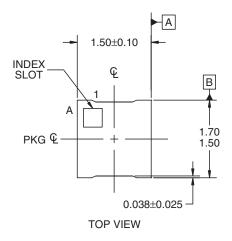


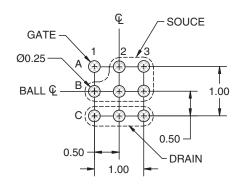
Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

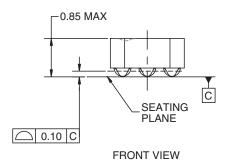
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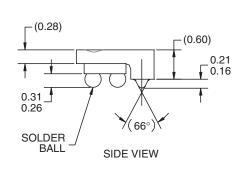
### **Dimensional Pad and Layout**

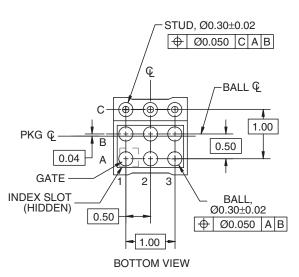




LAND PATTERN RECOMMENDATION







#### NOTES: UNLESS OTHERWISE SPECIFIED

- A) ALL DIMENSIONS ARE IN MILLIMETERS.
- B) NO JEDEC REGISTRATION REFERENCE AS OF SEPTEMBER 2003.
- C) BALL/STUD CONFIGURATION TABLE

TERMINAL ID		DESIGNATION	TERMINAL TYPE		
(	C1,C2,C3	DRAIN	COPPER STUD		
1	<b>A1</b>	GATE	BALL		
1	A2,A3,B1,B2,B3	SOURCE			

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GlobalOptoisolator™	MicroPak™	QFET®	SuperSOT™-8
GTO™ .	MICROWIRE™	$QS^{TM}$	SyncFET™
HiSeC™	MSX <sup>TM</sup>	QT Optoelectronics™	TinyLogic <sup>®</sup>
I <sup>2</sup> C <sup>TM</sup>	MSXPro™	Quiet Series™	TINYOPTO™
<i>i-</i> Lo <sup>™</sup>	$OCX^{TM}$	RapidConfigure™	TruTranslation™
ImpliedDisconnect™	OCXPro™	RapidConnect™	UHC™
es <sup>tin</sup>	OPTOLOGIC®	μSerDes™	UltraFET®
d. Around the world.™ chise® active Droop™	OPTOPLANAR <sup>TM</sup> PACMAN <sup>TM</sup> POP <sup>TM</sup>	SILENT SWITCHER® SMART START™ SPM™	UniFET™ VCX™
	FASTr <sup>TM</sup> FPS <sup>TM</sup> FRFET <sup>TM</sup> GlobalOptoisolator <sup>TM</sup> GTO <sup>TM</sup> HiSeC <sup>TM</sup> I <sup>2</sup> C <sup>TM</sup> i-Lo <sup>TM</sup> ImpliedDisconnect <sup>TM</sup> es <sup>TM</sup> d. Around the world. <sup>TM</sup>	FASTrTM FPSTM MICROCOUPLERTM MicroFETTM MicroPakTM MICROWIRETM MICROCOUPLERTM	FASTrTM LittleFETTM PowerEdgeTM FPSTM MICROCOUPLERTM PowerSaverTM FRFETTM MicroFETTM PowerTrench® GlobalOptoisolatorTM MicroPakTM QFET® GTOTM MICROWIRETM QSTM HISeCTM MSXTM QT OptoelectronicsTM PCTM MSXProTM Quiet SeriesTM i-LoTM OCXTM RapidConfigureTM ImpliedDisconnectTM OCXTM RapidConnectTM esTM OPTOLOGIC® µSerDesTM d. Around the world.TM Chise® PACMANTM SMART STARTTM Chise® SMART STARTTM

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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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